2025년 2월 12일(수)-14일(금) | 강원도 하이원리조트

Future Normal in Semiconductor

2025-02-14(금), 15:10-17:10

좌장: 추후업데이트 예정

B. Patterning (Lithography & Etch Technology) 분과 [FL3-B] Etch

초청 FL3-B-1 15:10-15:40	Semiconductor Equipment Technology: What's Next? Dougyong Sung Mechatronics Research, Samsung Electronics Co., Ltd.
FL3-B-2 15:40-15:55	Low-temperature SiO ₂ contact hole etching using C ₄ F ₈ plasmas 유상현 ^{1,2} , 김창구 ^{1,2} ¹ Department of Chemical Engineering, Ajou University, ² Department of Energy Systems Research, Ajou University
FL3-B-3 15:55-16:10	High-throughput Isotropic Atomic Layer Etching of Hafnia Films Using F Radicals and Al Precursors Gyejun Cho, Jehwan Hong, Hye-Lee Kim, and Won-Jun Lee Department of Nanotechnology and Advanced Materials Eng., Sejong University
초청 FL3-B-4 16:10-16:40	Technical Challenge and Development of HARC Etching Sang Wook Park, Jae Won Lee, Sang Heon Song, Kyung Tae Kim, Ki Jun Yun, Hoo Woong Lee, Woo June Kwon, Chung Won Seo, and Hyun Min Lee SK hynix
FL3-B-5 16:40-16:55	Investigation on the Effect of Tailored Waveform Bias on the Formation of SiO2/Si Trench Etch Profile in SF6/O2/Ar Plasma Taejun Park ¹ , Jihoon Park ¹ , Ingyu Lee ¹ , Namkyun Kim ² , and Gon-Ho Kim ¹ ¹ Seoul National University, ² Samsung Electronics
FL3-B-6 16:55-17:10	Ultrathin Ni catalyst for CMOS-compatible Metal-assisted Chemical Etching of Si Kyunghwan Kim ^{1,2} , Haekyun Bong ^{1,3} , and Jungwoo Oh ^{1,3} ¹ School of Integrated Technology, Yonsei University, ² Center for Quantum Technology, KIST, ³ BK21 Graduate Program in Intelligent Semiconductor Technology, Yonsei University

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초청

FM3-T-1 15:10-15:40 Mobilint Al Chips: Powering On-device and On-premises Al

Dongjoo Shin

Mobilint, Inc., Korea